

## CLAIM AMENDMENT

The Applicants cancel claims **1-6** and **35-63**.

1. – 6. *(cancelled)*

7. *(previously amended)* A metal embedded sensor comprising:  
    a. a metal structure comprising:  
        i. a metal having a melting temperature above 660°C;  
        ii. a coating metallic layer;  
        iii. an embedding metallic layer on the coating metallic layer; and  
    b. a sensor embedded inside the metal structure;  
and  
wherein said metal structure is in direct adhesive contact with said sensor.

8. *(cancelled)*

9. *(previously amended)* The metal embedded sensor of claim 7, wherein the embedding metallic layer is formed by laser deposition.

10. *(previously amended)* The metal embedded sensor of claim 7, wherein the coating metallic layer comprises a first metallic layer, and a second metallic layer on the first metallic layer.

11. *(original)* The metal embedded sensor of claim 10, wherein one or more of the first and the second metallic layers is formed by sputtering.

12. *(original)* The metal embedded sensor of claim 10, wherein one or more of the first and the second metallic layers is formed by electroplating.

13. *(original)* The metal embedded sensor of claim 10, wherein the first metallic layer is formed by sputtering, and the second metallic layer is formed by electroplating.
14. *(original)* The metal embedded sensor of claim 10, wherein the thickness of the first metallic layer is between about one and about three microns.
15. *(original)* The metal embedded sensor of claim 10, wherein the first metallic layer comprises a metal selected from the group consisting of copper, nickel, iron, and platinum.
16. *(original)* The metal embedded sensor of claim 10, wherein the thickness of the second metallic layer is between about one-quarter and about two millimeters.
17. *(original)* The metal embedded sensor of claim 10, wherein the second metallic layer comprises a metal selected from the group consisting of copper, nickel, iron, and platinum.
18. *(original)* The metal embedded sensor of claim 17, wherein the sensor is in the form of a fiber optic sensor.
19. *(original)* The metal embedded sensor of claim 18, further comprising an adhesive layer coating the sensor.
20. *(original)* The metal embedded sensor of claim 19, wherein the adhesive layer comprises titanium.

21. *(original)* The metal embedded sensor of claim 20, wherein the thickness of the adhesive layer is between about 2nm and about 3nm.
22. *(previously amended)* The metal embedded sensor of claim 7, wherein the sensor is in the form of a thin film thermo-mechanical sensor, and wherein the metal structure comprises:
- a. a coating metallic layer comprising
    - i. a first metallic layer;
    - ii. a second metallic layer on the first metallic layer, said second metallic layer selected from the group consisting of copper, nickel, iron, and platinum; and
  - b. an embedding metallic layer on the coating metallic layer.
23. *(previously amended)* The metal embedded sensor of claim 22, wherein the sensor comprises:
- a. a first insulating layer ;
  - b. a sensor layer disposed on the first insulating layer;
  - c. a second insulating layer disposed on the sensor layer; and
- wherein said first insulating layer and said second insulating layers are deposited of an insulating material with a maximum thickness for providing adequate electric insulation of said sensor layer in operation.
24. *(original)* The metal embedded sensor of claim 23, wherein the sensor further comprises an adhesive layer contacting the first insulating layer.
25. *(original)* The metal embedded sensor of claim 24, wherein the adhesive layer comprises titanium.
26. *(original)* The metal embedded sensor of claim 25, wherein the thickness of the adhesive layer is between about 2nm and about 3nm.

27. *(original)* The metal embedded sensor of claim 26, wherein the sensor further comprises a substrate contacting the adhesive layer.

28. *(original)* The metal embedded sensor of claim 27, wherein the substrate comprises a metallic substrate.

29. *(original)* The metal embedded sensor of claim 28, wherein the substrate comprises stainless steel.

30. *(original)* The metal embedded sensor of claim 23, wherein the sensor layer comprises constantan.

31. *(original)* The metal embedded sensor of claim 23, wherein the thickness of the first insulating layer is between about 10nm and about 15nm.

32. *(original)* The metal embedded sensor of claim 23, wherein the thickness of the second insulating layer is between about 10nm and about 15nm.

33. *(original)* The metal embedded sensor of claim 23, wherein the first and the second insulating layers comprise insulating oxides.

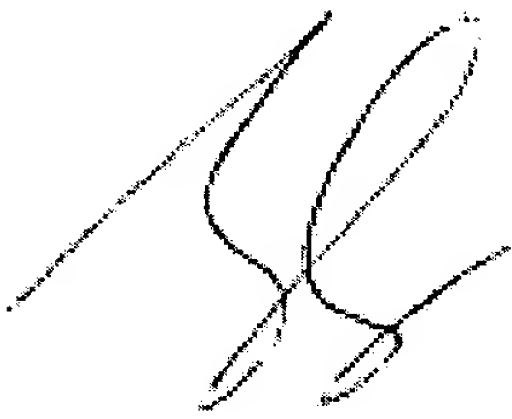
34. *(original)* The metal embedded sensor of claim 33, wherein the first and the second insulating layers comprise alumina.

35. – 63. *(cancelled)*

*IN CONCLUSION*

The Applicants have cancelled the withdrawn claims and respectfully request the application being reconsidered and allowed in the next Office Action.

Respectfully submitted,

A handwritten signature in black ink, appearing to be 'JS' or similar initials, written in a cursive style.

Johannes Schneeberger

Reg. No. 48,910

direct: 415-389-8766

Lumen Intellectual Property Services

2345 Yale Street, Suite 200

Palo Alto, CA 94306

voice: 650-424-0100

fax: 650-424-0141